

UTTAR PRADESH TECHNICAL UNIVERSITY LUCKNOW



SYLLABUS 2nd Year

[Effective from Session 2014-15]

- 1. B.Tech. Electronics Engineering**
- 2. B.Tech. Electronics & Communication Engineering**
- 3. B.Tech. Electronics & Telecommunication Engineering**
- 4. B.Tech. Electronics & Instrumentation Engineering**
- 5. B.Tech. Instrumentation & Control Engineering**
- 6. B. Tech. Applied Electronics and Control Engineering**
- 7. B. Tech. Biomedical Engineering**

STUDY AND EVALUATION SCHEME

B.Tech. Electronics Engineering, B.Tech. Electronics & Communication Engineering, B.Tech. Electronics & Telecommunication Engineering, B.Tech. Electronics & Instrumentation Engineering, B.Tech. Instrumentation & Control Engineering, B. Tech. Applied Electronics and Control Engineering, B. Tech. Biomedical Engineering
[Effective from Session 2014-15]

YEAR 2ND

SEMESTER-III

S.No.	Subject Code	Name of Subject	Periods			Evaluation Scheme				Subject Total	Credit
			L	T	P	CT	TA	Total	ESC		
1.	NAS-301/ NOE-031- NOE-039	Engg. Mathematics- III/Science based Electives*	3	1	0	30	20	50	100	150	4
2.	NEC-301	Network Analysis & Synthesis	3	1	0	30	20	50	100	150	4
3.	NEC-302	Fundamental of Electronic Devices	3	1	0	30	20	50	100	150	4
4.	NEC-303	Signals and Systems	3	1	0	30	20	50	100	150	4
5.	NHU-301/ NHU-302	Industrial Psychology/Industrial Sociology	2	0	0	15	10	25	50	75	2
6.	NEC-304	Switching Theory & Logic Design	2	1	0	15	10	25	50	75	3
	AUC-001/ AUC-002	Human Values & Professional Ethics/Cyber Security	2	0	0	15	10	25	50	75**	--
PRACTICAL/DESIGN/DRAWING											
7.	NEC-351	Network Analysis & Synthesis Lab.	0	0	3	10	10	20	30	50	1
8.	NEC-352	Electronics Workshop & PCB Design	0	0	3	10	10	20	30	50	1
9.	NEC-353	Logic Design Lab.	0	0	2	10	10	20	30	50	1
10.	NEC-354	Electronic Device Lab.	0	0	2	10	10	20	30	50	1
11.	NGP-301	NGP						50		50	--
		Total	18	5	10					1000	25

Science Based Open Elective:

NOE031	Introduction to Soft Computing (Neural Network, Fuzzy Logic and Genetic Algorithm)
NOE032	Nano Sciences
NOE033	Laser Systems and Applications
NOE034	Space Sciences
NOE035	Polymer Science & Technology
NOE036	Nuclear Science
NOE037	Material Science
NOE038	Discrete Mathematics
NOE039	Applied Linear Algebra

*Human values & Professional Ethics /Cyber Security will be offered as a compulsory audit course for which passing marks are 30% in End Semester Examination and 40% in aggregate.

STUDY AND EVALUATION SCHEME

B.Tech. Electronics Engineering, B.Tech. Electronics & Communication Engineering, B.Tech. Electronics & Telecommunication Engineering, B.Tech. Electronics & Instrumentation Engineering, B.Tech. Instrumentation & Control Engineering, B. Tech. Applied Electronics and Control Engineering, B. Tech. Biomedical Engineering
[Effective from Session 2014-15]

YEAR 2ND

SEMESTER-IV

S.No.	Subject Code	Name of Subject	Periods			Evaluation Scheme				Subject Total	Credit
			L	T	P	CT	TA	Total	ESC		
1.	NOE-041- NOE-049/ NAS-401	Science based Elective/Engg. Mathematics-III	3	1	0	30	20	50	100	150	4
2.	NEC-401	Data Structure	3	1	0	30	20	50	100	150	4
3.	NEC-402	Electronic Circuits	3	1	0	30	20	50	100	150	4
4.	NEC-408	Electronic Measurements & Instrumentation	3	1	0	30	20	50	100	150	4
5.	NHU-401/ NHU-402	Industrial Sociology/ Industrial Psychology	2	0	0	15	10	25	50	75	2
6.	NEC-404	Electromagnetic Field Theory (EMFT)	2	1	0	15	10	25	50	75	3
7.	AUC-002/ AUC-001	Cyber Security/ Human Values & Professional Ethics	2	0	0	15	10	25	50	75**	--
PRACTICAL/DESIGN/DRAWING											
8.	NEC-451	Data Structure Lab.	0	0	3	10	10	20	30	50	1
9.	NEC-452	Electronic Circuits Lab.	0	0	3	10	10	20	30	50	1
10.	NEC-453	Digital Electronics Lab.	0	0	2	10	10	20	30	50	1
11.	NEC-454	Electronics Measurement Lab.	0	0	2	10	10	20	30	50	1
12.	NGP-401	NGP						50		50	--
		Total				40				1000	25

Science Based Open Elective:

- NOE-041 Introduction to Soft Computing (Neural Network, Fuzzy Logic and Genetic Algorithm)
- NOE-042 Nano Sciences
- NOE-043 Laser Systems and Applications
- NoE-044 Space Sciences
- NOE-045 Polymer Science & Technology
- NOE-046 Nuclear Science
- NOE-047 Material Science
- NOE-048 Discrete Mathematics
- NOE-049 Applied Linear Algebra

*Human values & Professional Ethics /Cyber Security will be offered as a compulsory audit course for which passing marks are 30% in End Semester Examination and 40% in aggregate.

Syllabus Third semester

THEORY SUBJECTS

NEC-301 NETWORK ANALYSIS & SYNTHESIS			3 1 0
Unit	Topic	Chapter/ Section	Proposed number of Lectures
I.	Signal analysis, complex frequency, network analysis, network synthesis, General characteristics and descriptions of signals, step function and associated wave forms, The unit impulse Introduction to network analysis, network elements, initial and final conditions, step and impulse response, solution of network equations,	1.1 to 1.4 2.1 to 2.3 5.1 to 5.5	10
II.	Review of Laplace transforms, poles and zeroes, initial and final value theorems, The transform circuit, Thevenin's and Norton's theorems, the system function, step and impulse responses, the convolution integral. Amplitude and phase responses. Network functions, relation between port parameters, transfer functions using two port parameters, interconnection of two ports.	7.1 to 7.5 8.1 9.1 to 9.4	8
III.	Hurwitz polynomials, positive real functions. Properties of real immittance functions, synthesis of LC driving point immittances, properties of RC driving point impedances, synthesis of RC impedances or RL admittances, properties of RL impedances and RC admittances.	10.2,10.3 11.1 to 11.5	8
IV.	Properties of transfer functions, zeroes of transmission, synthesis of Y_{21} and Z_{21} with 1 terminations.	12.1 to 12.3	6
V.	Introduction to active network synthesis Active Network Synthesis	Material available on UPTU website & 8.7 (Text Book 2)	8
<p>Text Book: 1. Franklin F. Kuo, "Network Analysis and synthesis", 2nd Edition, Wiley India Pvt Ltd. 2. Behrouz Peikari, "Fundamentals of Network Analysis & synthesis", Jaico Publishing House, 2006.</p> <p>Reference Books: M. E. Van Valkenberg, "Network Analysis", 2nd Edition, Prentice Hall of India Ltd. Ghosh-Network Theory: Analysis and Synthesis, PHI Learning Pvt. Ltd</p>			

NEC-302 FUNDAMENTAL OF ELECTRONIC DEVICES			3 1 0
Unit	Topic	Chapter/ Section	Proposed number of Lectures
I.	Crystal Properties and charge Carriers in Semiconductors: Elemental and compound semiconductor materials, crystal lattice structure, Bonding forces and energy bands in solids, charge carriers in semiconductors, carrier concentrations, drift of carriers in electric and magnetic fields.	1.1 to 1.2 3.1 to 3.4	8
II.	Excess Carriers in Semiconductors: Optical absorption, luminescence, carrier life time and photo conductivity, diffusion of carriers.	4.1 to 4.3 and 4.4.1 to 4.4.4	8
III.	Junction Properties: Equilibrium conditions, biased junctions, steady state conditions, reverse bias break down, transient and AC conditions. Metal semiconductor junctions.	5.2 to 5.5 5.7	8
IV.	Transistors: Metal-semiconductor-field-effect-transistors (MESFET), Metal-insulator-semiconductor-field-effect-transistors (MISFET), Metal oxide semiconductor field effect transistor (MOSFET): Construction, Operation and characteristics of above devices. Bipolar junction transistors: Fundamentals of BJT operation, amplification with BJTs	6.3.1 to 6.3.2, 6.4.1 to 6.4.2, 6.5.1 to 6.5.2 7.1 to 7.2	8
V.	Some special devices: Photodiodes, photo detectors, solar cell, light emitting diodes, semi-conductor lasers, light emitting materials. Tunnel Diode: degenerate semiconductors, IMPATT diode; The transferred electron mechanism: The GUNN diode. P-N-P-N diode, semiconductor controlled rectifier (SCR), bilateral devices: DIAC, TRIAC, IGBT.	8.1, 8.2.1, 8.2.3, 8.3, 8.4; 10.1 10.2 10.3.1, 10.3.2 11.1 to 11.3	8
Text Book: B. G. Streetman and S. Banerjee “Solid state electronics devices”, 5th Edition, PHI.			
Reference Books:1. Alok Dutta, “Semiconductor Devices and circuits”, Oxford University Press. 2. Donald A Neaman, “Semiconductor Physics and Devices Basic Principles” 3rd Ed TMH India.			

NEC-303 SIGNALS AND SYSTEMS			3 1 0
Unit	Topic	Chapter/ Section	Proposed number of Lectures
I.	Signals: Definition, types of signals and their representations: continuous-time/discrete-time, periodic/non-periodic, even/odd, energy/power, deterministic/ random, one-dimensional/multidimensional; commonly used signals (in continuous-time as well as in discrete-time): unit impulse, unit step, unit ramp (and their interrelationships), exponential, rectangular pulse, sinusoidal; operations on continuous-time and discrete-time signals (including transformations of independent variables).	1.1 to 1.5	6
II.	Laplace-Transform (LT) and Z-transform (ZT): (i) One-sided LT of some common signals, important theorems and properties of LT, inverse LT, solutions of differential equations using LT, Bilateral LT, Regions of convergence (ROC) (ii) One sided and Bilateral Z-transforms, ZT of some common signals, ROC, Properties and theorems, solution of difference equations using one-sided ZT, s- to z-plane mapping	2.1 to 2.15	3+5
III.	Fourier Transforms (FT): (i) Definition, conditions of existence of FT, properties, magnitude and phase spectra, Some important FT theorems, Parseval's theorem, Inverse FT, relation between LT and FT (ii) Discrete time Fourier transform (DTFT), inverse DTFT, convergence, properties and theorems, Comparison between continuous time FT and DTFT	4.1 4.11; 5.1 to 5.7	6+4
IV.	Systems: Classification, linearity, time-invariance and causality, impulse response, characterization of linear time-invariant (LTI) systems, unit sample response, convolution summation, step response of discrete time systems, stability. Convolution integral, co-relations, signal energy and energy spectral density, signal power and power spectral density, properties of power spectral density,	7.1 to 7.12; 9.2, 9.6 to 9.8	8
V.	Time and frequency domain analysis of systems Analysis of first order and second order systems, continuous-time (CT) system analysis using LT, system functions of CT systems, poles and zeros, block diagram representations; discrete-time system functions, block diagram representation, illustration of the concepts of system bandwidth and rise time through the analysis of a first order CT low pass filter	8.1-8.6; 8.8	10
Text Book: P. Ramakrishna Rao, 'Signal and Systems' 2008 Ed., Tata McGraw Hill, New Delhi			
Reference Books: Chi-Tsong Chen, 'Signals and Systems', 3rd Ed., Oxford University Press, 2004 V. Oppenheim, A.S. Willsky & S. Hamid Nawab, 'Signals & System', Pearson Education, 2 nd Ed., 2003.			

NEC-304 SWITCHING THEORY AND LOGIC DESIGN			2 1 0
Unit	Topic	Chapter/ Section	Proposed number of Lectures
I.	Digital system and binary numbers: Signed binary numbers, binary codes. Gate-level minimization: The map method up to four variable, don't care conditions, POS simplification, NAND and NOR implementation, Quine Mc-Clusky method (Tabular method).	1.6, 1.7, 7.4 3.1 to 3.7, 3.10	5
II.	Combinational Logic: Combinational circuits, analysis procedure, design procedure, binary adder-subtractor, decimal adder, binary multiplier, magnitude comparator, decoders, encoders, multiplexers	4.1 to 4.11	8
III.	Synchronous Sequential logic: Sequential circuits, storage elements: latches, flip flops, analysis of clocked sequential circuits, state reduction and assignments, design procedure. Asynchronous Sequential logic: Analysis procedure, circuit with latches, design procedure, reduction of state and flow table, race free state assignment, hazards.	5.1 to 5.5, 5.7 to 5.8 9.1 to 9.7	9
IV.	Registers and counters: Shift registers, ripple counter, synchronous Counter, other counters. Memory and programmable logic: RAM, ROM, PLA, PAL.	6.1 to 6.5 7.1 to 7.3, 7.5to 7.7	8
Text Book: M. Morris Mano and M. D. Ciletti, "Digital Design", 4 th Edition, Pearson Education			
Reference Books: 1. Hill & Peterson, "Switching Circuit & Logic Design", Wiley. 2. Mohammad A. Karim and Xinghao Chen, "Digital Design-Basic concepts and Principles", CRC Press Taylor & Francis group, 2010.			

LABORATORY

NEC- 351 NETWORK ANALYSIS & SYNTHESIS LAB

1. Study and verification of network theorems with input signal of 1 kHz, 10kHz and 100kHz.
2. Verification of two port network parameters
3. Step and Ramp response of series and parallel RC circuits
4. Verification of properties of RC circuits
5. Verification of properties of RL circuits
6. Verification of properties of LC circuits
7. Verification of inverting, non-inverting and voltage follower VCVS circuits using 741 op-amp
8. Verification of inverting integrator using 741 op-amp
9. Design a finite gain differential amplifier with infinite input impedance and verify the output response.

NEC- 352 ELECTRONIC WORKSHOP & PCB LAB

Objective: To create interest in Hardware Technology.

1. Study of CRO, DMM & Function Generator
2. Identification of Active & Passive Components
3. Winding shop: Step down transformer winding of less than 5VA.
4. Soldering shop: Fabrication of DC regulated power supply
5. PCB Lab: (a) Artwork & printing of a simple PCB. (b) Etching & drilling of PCB.
6. Wiring & fitting shop: Fitting of power supply along with a meter in cabinet.
7. Testing of regulated power supply fabricated.

NEC- 353 LOGIC DESIGN LAB

Objective: To understand the digital logic and create various systems by using these logics.

1. Introduction to digital electronics lab- nomenclature of digital ICs, specifications, study of the data sheet, Concept of V_{cc} and ground, verification of the truth tables of logic gates using TTL ICs.
2. Implementation of the given Boolean function using logic gates in both SOP and POS forms.
3. Verification of state tables of RS, JK, T and D flip-flops using NAND & NOR gates.
4. Implementation and verification of Decoder/De-multiplexer and Encoder using logic gates.
5. Implementation of 4x1 multiplexer using logic gates.
6. Implementation of 4-bit parallel adder using 7483 IC.
7. Design, and verify the 4-bit synchronous counter.
8. Design, and verify the 4-bit asynchronous counter.
9. Mini Project (Imp)

NEC- 354 ELECTRONIC DEVICES LAB.

Objective: To attain expertise in lab equipment handling and understanding the basic devices, their properties, Characteristics in detail. Along with their practical usage in the circuit

1. **Study of lab equipments and components:** CRO, Multimeter, Function Generator, Power supply- Active, Passive Components & Bread Board.
2. **P-N Junction Diode:** Characteristics of PN Junction diode-Static and dynamic resistance measurement from graph.
3. **Applications of PN junction diode:** Half & Full wave rectifier- Measurement of V_{rms} , V_{dc} , and ripple factor-use of filter- ripple reduction (RC Filter)-Clipper & Clamper
4. **Properties of junctions** Zener diode characteristics. Heavy doping alters the reverse characteristics. Graphical measurement of forward and reverse resistance.
5. **Application of Zener diode:** Zener diode as voltage regulator. Measurement of percentage regulation by varying load resistor.
6. **Characteristic of BJT:** BJT in CB and CE configuration- Graphical measurement of h parameters from input and output characteristics. Measurement of A_v , A_i , R_o and R_i of CE amplifier with potential divider biasing.
7. **Characteristic of FET:** FET in common source configuration. Graphical measurement of its parameters g_m , r_d & m from input and output characteristics.
8. **Characteristic** of silicon-controlled rectifier.
9. **To plot** V-I Characteristics of DIAC.
10. **To draw** V-I characteristics of TRIAC for different values of Gate Currents.

Syllabus fourth semester

THEORY SUBJECTS

NEC-401 DATA STRUCTURE		3 1 0
Unit	Topic	Proposed number of Lectures
I.	Introduction: Basic Terminology, Elementary Data Organization, Algorithm, Efficiency of an Algorithm, Time and Space Complexity, Asymptotic notations: Big-Oh, Time-Space trade-off. Abstract Data Types (ADT) Arrays: Definition, Single and Multidimensional Arrays, Representation of Arrays: Row Major Order, and Column Major Order, Application of arrays, Sparse Matrices and their representations. Linked lists: Array Implementation and Dynamic Implementation of Singly Linked Lists, Doubly Linked List, Circularly Linked List, Operations on a Linked List. Insertion, Deletion, Traversal, Polynomial Representation and Addition, Generalized Linked List	8
II.	Stacks: Abstract Data Type, Primitive Stack operations: Push & Pop, Array and Linked Implementation of Stack in C, Application of stack: Prefix and Postfix Expressions, Evaluation of postfix expression, Recursion, Tower of Hanoi Problem, Simulating Recursion, Principles of recursion, Tail recursion, Removal of recursion Queues, Operations on Queue: Create, Add, Delete, Full and Empty, Circular queues, Array and linked implementation of queues in C, Dequeue and Priority Queue.	8
III.	Trees: Basic terminology, Binary Trees, Binary Tree Representation: Array Representation and Dynamic Representation, Complete Binary Tree, Algebraic Expressions, Extended Binary Trees, Array and Linked Representation of Binary trees, Tree Traversal algorithms: In order, Preorder and Post order, Threaded Binary trees, Traversing Threaded Binary trees, Huffman algorithm.	8
IV.	Graphs: Terminology, Sequential and linked Representations of Graphs: Adjacency Matrices, Adjacency List, Adjacency Multi list, Graph Traversal : Depth First Search and Breadth First Search, Connected Component, Spanning Trees, Minimum Cost Spanning Trees: Prims and Kruskal algorithm. Transitive Closure and Shortest Path algorithm: Warshal Algorithm and Dijkstra Algorithm, Introduction to Activity Networks	8
V.	Searching : Sequential search, Binary Search, Comparison and Analysis Internal Sorting: Insertion Sort, Selection, Bubble Sort, Quick Sort, Two Way Merge Sort, Heap Sort, Radix Sort	8
<p>Text book:</p> <ol style="list-style-type: none"> 1. Aaron M. Tenenbaum, Yedidiah Langsam and Moshe J. Augenstein “Data Structures Using C and C++”, PHI <p>References</p> <ol style="list-style-type: none"> 1. Horowitz and Sahani, “Fundamentals of Data Structures”, Galgotia Publication 2. Jean Paul Trembley and Paul G. Sorenson, “An Introduction to Data Structures with applications”, McGraw Hill 3. R. Kruse etal, “Data Structures and Program Design in C”, Pearson Education 4. Lipschutz, “Data Structures” Schaum’s Outline Series, TMH 5. G A V Pai, “Data Structures and Algorithms”, TMH 		

NEC-402 ELECTRONIC CIRCUITS			3 1 0
Unit	Topic	Chapter/ Section	Proposed number of Lectures
I.	Operational Amplifier: Inverting and non-inverting configurations, difference amplifier, Effect of finite open loop gain and bandwidth on circuit performance, Large signal operation of op-amp.	2.2 to 2.6	8
II.	MOSFET: Review of device structure operation and V-I characteristics. Circuits at DC, MOSFET as Amplifier and switch, Biasing in MOS amplifier circuits, small-signal operation and models, single stage MOS amplifier, MOSFET internal capacitances and high frequency model, frequency response of CS amplifier	4.3 to 4.9 and 4.11	8
III.	BJT: Review of device structure operation and V-I characteristics, BJT circuits at DC, BJT as amplifier and switch, biasing in BJT amplifier circuit, small-signal operation and models, single stage BJT amplifier, BJT internal capacitances and high frequency model, frequency response of CE amplifier.	5.3 to 5.9	8
IV.	Differential Amplifier: MOS differential pair, small signal operation of the MOS differential pair, BJT differential pair, other non-ideal characteristic of the Differential amplifier (DA), DA with active load.	7.1 to 7.5	9
V.	Feedback: The general feedback structure, properties of negative feedback, the four basic feedback topologies, the series-shunt feedback amplifier, the series-series feedback amplifier, the shunt-shunt and shunt-series feedback amplifier. Oscillators: Basic principles of sinusoidal oscillators, op-amp RC oscillator circuits, LC oscillator.	8.1 to 8.6 13.1 to 13.3	7
Text Book: A. S. Sedra and K. C. Smith, "Microelectronic Circuits", Oxford University Press, 5th Ed.			
Reference Books: Jacob Millman and Arvin Grabel, "Microelectronics", 2nd Ed TMH			

NEC-403 ELECTRONIC MEASUREMENTS AND INSTRUMENTATION			3 1 0
Unit	Topic	Chapter/ Section	Proposed number of Lectures
I.	Unit, dimensions and standards: Scientific notations and metric prefixes. SI electrical units, SI temperature scales, Other unit systems, dimension and standards. Measurement Errors: Gross error, systematic error, absolute error and relative error, accuracy, precision, resolution and significant figures, Measurement error combination, basics of statistical analysis. PMMC instrument, galvanometer, DC ammeter, DC voltmeter, series ohm meter.	1.1 to 1.7 2.1 to 2.5 3.1 to 3.4	8
II.	Transistor voltmeter circuits, AC electronic voltmeter, current measurement with electronic instruments, probes Digital voltmeter systems, digital multimeters, digital frequency meter system	4.1, 4.2, 4.4, 4.5, 4.7 6.1 to 6.3	8
III.	Voltmeter and ammeter methods, Wheatstone bridge, low resistance measurements, low resistance measuring instruments AC bridge theory, capacitance bridges, Inductance bridges, Q meter	7.1, 7.3, 7.4,7.5 8.2 to 8.4, 8.9	8
IV.	CRO: CRT, wave form display, time base, dual trace oscilloscope, measurement of voltage, frequency and phase by CRO, Oscilloscope probes, Oscilloscope specifications and performance. Delay time based Oscilloscopes, Sampling Oscilloscope, DSO, DSO applications	9.1, 9.3, 9.4,9.5, 9.7, 9.9, 9.12,10.1, 10.3,10.4, 10.5	8
V.	Instrument calibration: Comparison method, digital multimeters as standard instrument, calibration instrument Recorders: X-Y recorders, plotters	12.1, 12.2 ,12.3, 13.2, 13.4	8
Text Book: David A. Bell, "Electronic Instrumentation and Measurements", 2nd Ed., PHI , New Delhi 2008.			
Reference Books: Oliver and Cage, "Electronic Measurements and Instrumentation", TMH, 2009. Alan S. Morris, "Measurement and Instrumentation Principles", Elsevier (Buterworth Heinmann), 2008.			

NEC-404 ELECTROMAGNETIC FIELD THEORY			2 1 0
Unit	Topic	Chapter/ Section	Proposed number of Lectures
I.	Coordinate systems and transformation: Cartesian coordinates, circular cylindrical coordinates, spherical coordinates Vector calculus: Differential length, area and volume, line surface and volume integrals, del operator, gradient of a scalar, divergence of a vector and divergence theorem, curl of a vector and Stoke's theorem, Laplacian of a scalar.	2.1 to 2.4 3.1 to 3.8	6
II.	Electrostatics: Electrostatic fields, Coulombs law and field intensity, Electric field due to charge distribution, Electric flux density, Gausses's Law – Maxwell's equation, Electric dipole and flux lines, energy density in electrostatic fields. Electric field in material space: Properties of materials, convection and conduction currents, conductors, polarization in dielectrics, dielectric constants, continuity equation and relaxation time, boundary condition. Electrostatic boundary value problems: Poission's and Laplace's equations, general procedures for soling Poission's or Laplace's equations, resistance and capacitance, method of images.	to 4.9 5.1 to 5.6, 5.8, 5.9 6.1, 6.2, 6.4 to 6.6	10
III.	Magnetostatics: Magneto-static fields, Biot-Savart's Law, Ampere's circuit law, Maxwell's equation, application of ampere's law, magnetic flux density- Maxwell's equation, Maxwell's equation for static fields, magnetic scalar and vector potential. Magnetic forces, materials and devices: Forces due to magnetic field, magnetic torque and moment, a magnetic dipole, magnetization in materials, magnetic boundary conditions, inductors and inductances, magnetic energy.	7.1 to 7.7 8.1 to 8.9	8
IV.	Waves and applications: Maxwell's equation, Faraday's Law, transformer and motional electromotive forces, displacement current, Maxwell's equation in final form. Electromagnetic wave propagation: Wave propagation in lossy dielectrics, plane waves in lossless dielectrics, plane wave in free space, plain waves in good conductors, power and the pointing vector, reflection of a plain wave in a normal incidence.	9.1 to 9.5 10.1, 10.3 to 10.8	8
Text Book: M. N. O. Sadiku, "Elements of Electromagnetics", 4 th , Ed, Oxford University Press.			
Reference Books: W. H. Hayt and J. A. Buck, "Electromagnetic field theory", 7 th Ed., TMH. Pramanik-Electromagnetism: Vol.1-Theory, PHI Learning Pvt. Ltd			

LABORATORY

NEC- 451 DATA STRUCTURE LAB

Program in C or C++ for following:

1. To implement addition and multiplication of two 2D arrays.
2. To transpose a 2D array.
3. To implement stack using array.
4. To implement queue using array.
5. To implement circular queue using array.
6. To implement stack using linked list.
7. To implement queue using linked list.
8. To implement circular queue using linked list.
9. To implement binary tree using linked list.
10. To implement binary search tree using linked list.
11. To implement tree traversals using linked list.
12. To implement BFS using linked list.
13. To implement DFS using linked list.
14. To implement Linear Search.
15. To implement Binary Search.
16. To implement Bubble Sorting.
17. To implement Selection Sorting.
18. To implement Insertion Sorting.
19. To implement Merge Sorting.
20. To implement Heap Sorting.

NEC- 452 ELECTRONIC CIRCUITS LAB

Objective - To design and implement the circuits to gain knowledge on performance of the circuits and its applications.

Measurement of Operational Amplifier Parameters-Common Mode Gain, Differential Mode Gain, CMRR, Slew Rate.

Applications of Op-amp- Op-amp as summing amplifier, Difference amplifier, Integrator and differentiator

Field Effect Transistors-Single stage Common source FET amplifier –plot of gain in dB Vs frequency, Measurement of, bandwidth, input impedance, maximum signal handling capacity (MSHC) of an amplifier

Bipolar Transistors- Design of single stage RC coupled amplifier –design of DC biasing circuit using potential divider arrangement –Plot of frequency versus gain in dB. Measurement of bandwidth of an amplifier, input impedance and Maximum Signal Handling Capacity of an amplifier.

Two stage Amplifier. Plot of frequency Vs gain. Estimation of Q factor, bandwidth of an amplifier

Common Collector Configuration-Emitter Follower (using Darlington pair)-Gain and input impedance measurement of the circuit.

Power Amplifiers-Push pull amplifier in class B mode of operation –measurement of gain.

Differential Amplifier –Implementation of transistor differential amplifier .Non ideal characteristics of differential amplifier

Oscillators -Sinusoidal Oscillators- (a) Wein bridge oscillator (b) phase shift oscillator

Simulation of Amplifier circuits studied in the lab using any available simulation software and measurement of bandwidth and other parameters with the help of simulation software.

NEC- 453 DIGITAL ELECTRONIC LAB

1. TTL Transfer Characteristics and TTL IC Gates.
2. CMOS Gate Transfer Characteristics.
3. Implementation of a 3-bit SIPO and SISO shift registers using flip-flops.
4. Implementation of a 3-bit PIPO and PISO shift registers using flip-flops.
5. Design of Seven segment display driver for BCD codes.
6. BCD Adders & Subtractors
7. A L U
8. 8085 Assembly Language Programming

NEC- 454 ELECTRONIC MEASUREMENT LAB

1. Study of semiconductor diode voltmeter and its use as DC average responding AC voltmeter .
2. Study of L.C.R. bridge and determination of the value of the given components.
3. Study of distortion factor meter and determination of the % distortion of the given oscillator.
4. Study of the transistor tester and determination of the parameters of the given transistors.
5. Study of the following transducer (i) PT-100 trans (ii) J- type trans. (iii) K-type trans (iv) Presser trans
6. Measurement of phase difference and frequency using CRO (lissajous figure)
7. Measurement of low resistance Kelvin's double bridge.
8. Radio Receiver Measurements